


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/691,133	CHEN ET AL.	
	Examiner	Art Unit	
	Emmanuel Bayard	2611	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
375	229									
INTERNATIONAL CLASSIFICATION										
A03H	7130									
			/							
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(Assistant Examiner) (Date)		EMMANUEL BAYARD PRIMARY EXAMINER <i>Emmanuel Bayard</i> 9/19/06 (Primary Examiner) (Date)	Total Claims Allowed: 33	
<i>Rayway</i> 9/19/06 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 21

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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